Unit: mm

TOSHIBA Field Effect Transistor Silicon N/P Channel MOS Type( $\pi$ -MOSVI)

# SSM6L09FU

## Power Management Switch High Speed Switching Applications

• Small package

Low on-resistance Q1:  $RDS(ON) = 0.7 \Omega \text{ (max) } (@V_{GS} = 10 \text{ V})$ 

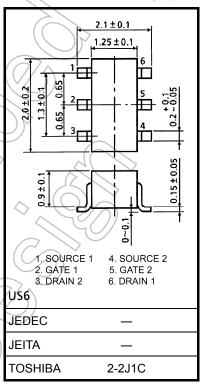
Q2:  $RDS(ON) = 2.7 \Omega (max) (@V_{GS} = -10 V)$ 

## Q1 Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit	
Drain-Source voltage		$V_{DSS}$	30	K.	
Gate-Source voltage		$V_{GSS}$	±20	(Y)	
Drain current	DC	ΙD	400	(mA)	
	Pulse	I <sub>DP</sub>	800		

## Q2 Absolute Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Drain-Source voltage		V <sub>DSS</sub>	V <sub>DSS</sub> -30	
Gate-Source voltage		V <sub>GS</sub> \$	±20	V
Drain current	DC	ID	<u>)</u> –200	mA
	Pulse	(TDP	-400	IIIA



Weight: 6.8 mg (typ.)

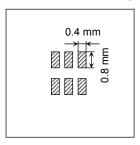
# Absolute Maximum Ratings (Q1, Q2 common) (Ta = 25°C)

Characteristics	Symbol	Rating	Unit
Power dissipation	P <sub>D</sub> (Note 1)	300	mW
Channel temperature	T <sub>ch</sub>	150	°C
Storage temperature range	T <sub>stg</sub>	-55 to 150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

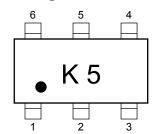
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Total rating, mounted on FR4 board (25.4 mm  $\times$  25.4 mm  $\times$  1.6 mm, Cu Pad: 0.32 mm $^2$   $\times$  6)

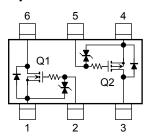


Start of commercial production 2001-02

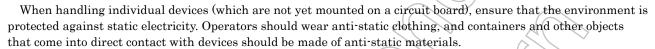
## Marking (top view)



## **Equivalent Circuit**



## **Handling Precaution**





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90%

10%

90%

10%

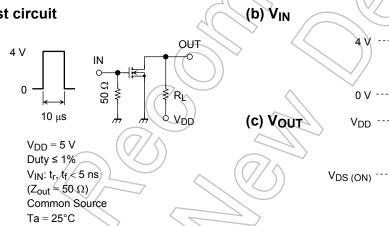
#### Q1 Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min.	Тур.	Max.	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0$	_	_	±1	μА
Drain-Source breakdo	wn voltage	V (BR) DSS	$I_D = 1 \text{ mA}, V_{GS} = 0$	30	_	_	V
Drain cut-off current		I <sub>DSS</sub>	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0	_	_	1	μА
Gate threshold voltage		V <sub>th</sub>	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 0.1 mA	1.1		1.8	V
Forward transfer admittance		Y <sub>fs</sub>	$V_{DS} = 5 \text{ V}, I_D = 200 \text{ mA}$ (Note2)	270	4	_	mS
Drain-Source on-resistance		R <sub>DS</sub> (ON)	I <sub>D</sub> = 200 mA, V <sub>GS</sub> = 10 V (Note2)		0.5	0.7	Ω
			I <sub>D</sub> = 200 mA, V <sub>GS</sub> = 4 V (Note2)	/ <del>()</del>	8.0	1.2	
			$I_D = 200 \text{ mA}, V_{GS} = 3.3 \text{ V}$ (Note2)		1.0	1.7	
Input capacitance		C <sub>iss</sub>		> —	20	_	pF
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = 5 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$	_	7	-	pF
Output capacitance		Coss	4( >>	_	16	4	pF
Switching time	Turn-on time	t <sub>on</sub>	V <sub>DD</sub> = 5 V, I <sub>D</sub> = 200 mA,	- /	72	_	no
	Turn-off time	t <sub>off</sub>	V <sub>GS</sub> = 0 to 4 V	-((	68	<u></u>	ns

Note2: Pulse test

#### **Switching Time Test Circuit**

(a) Test circuit





 $V_{
m th}$  can be expressed as the voltage between the gate and source when the low operating current value is ID = 0.1 mA for this product. For normal switching operation, VGS (on) requires a higher voltage than Vth and VGS (off) requires a lower voltage than Vth. (The relationship can be established as follows: VGS (off) < Vth < VGS (on).) Be sure to take this into consideration when using the device.

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#### **Q2 Electrical Characteristics (Ta = 25°C)**

Characteristics		Symbol	Test Condition	Min.	Тур.	Max.	Unit
Gate leakage current		I <sub>GSS</sub>	$V_{GS} = \pm 16 \text{ V}, V_{DS} = 0$	_	_	±1	μА
Drain-Source breakdown voltage		V (BR) DSS	$I_D = -1 \text{ mA}, V_{GS} = 0$	-30	_	_	V
Drain cut-off current		I <sub>DSS</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = 0$	_	_	-1	μА
Gate threshold voltage		V <sub>th</sub>	$V_{DS} = -5 \text{ V}, I_D = -0.1 \text{ mA}$	=1.1	_	-1.8	V
Forward transfer admittance		Y <sub>fs</sub>	$V_{DS} = -5 \text{ V}, I_D = -100 \text{ mA}$ (Note3)	115	1	_	mS
Drain-Source on-resistance		R <sub>DS</sub> (ON)	$I_D = -100 \text{ mA}, V_{GS} = -10 \text{ V (Note3)}$		2.1	2.7	Ω
			$I_D = -100 \text{ mA}, V_{GS} = -4 \text{ V}$ (Note3)	/ <del>()</del>	3.3	4.2	
			$I_D = -100 \text{ mA}, V_{GS} = -3.3 \text{ V(Note3)}$		4.0	6.0	
Input capacitance		C <sub>iss</sub>	$V_{DS} = -5 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$	> —	22	_	pF
Reverse transfer capacitance		C <sub>rss</sub>	$V_{DS} = -5 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$	_	5		pF
Output capacitance		Coss	$V_{DS} = -5 \text{ V}, V_{GS} = 0, f = 1 \text{ MHz}$	_	14	7	pF
Switching time	Turn-on time	t <sub>on</sub>	$V_{DD} = -5 \text{ V}, I_D = -100 \text{ mA},$	_ (	85	_	20
	Turn-off time	t <sub>off</sub>	V <sub>GS</sub> = 0 to -4 V	-((	85	_	ns

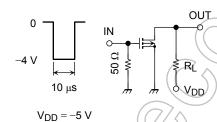
Note3: Pulse test

## **Switching Time Test Circuit**

Duty ≤ 1%

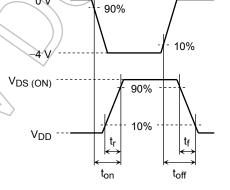
 $V_{IN}$ :  $t_r$ ,  $t_f < 5$  ns  $(Z_{out} = 50 \ \Omega)$  Common Source  $Ta = 25^{\circ}C$ 

(a) Test circuit



(b) V<sub>IN</sub>

(c) Vout



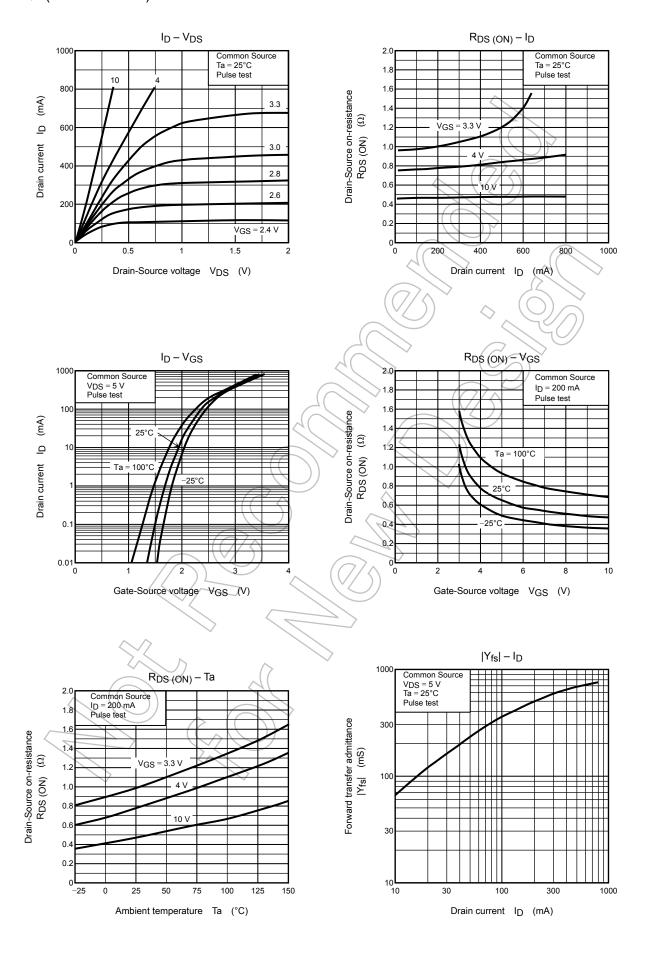
#### **Precaution**

 $V_{th}$  can be expressed as voltage between gate and source when low operating current value is ID = -0.1 mA for this product. For normal switching operation,  $V_{GS}$  (on) requires higher voltage than  $V_{th}$  and  $V_{GS}$  (off) requires lower voltage than  $V_{th}$ . (Relationship can be established as follows:  $V_{GS}$  (off)  $< V_{th} < V_{GS}$  (on))

Please take this into consideration for using the device.

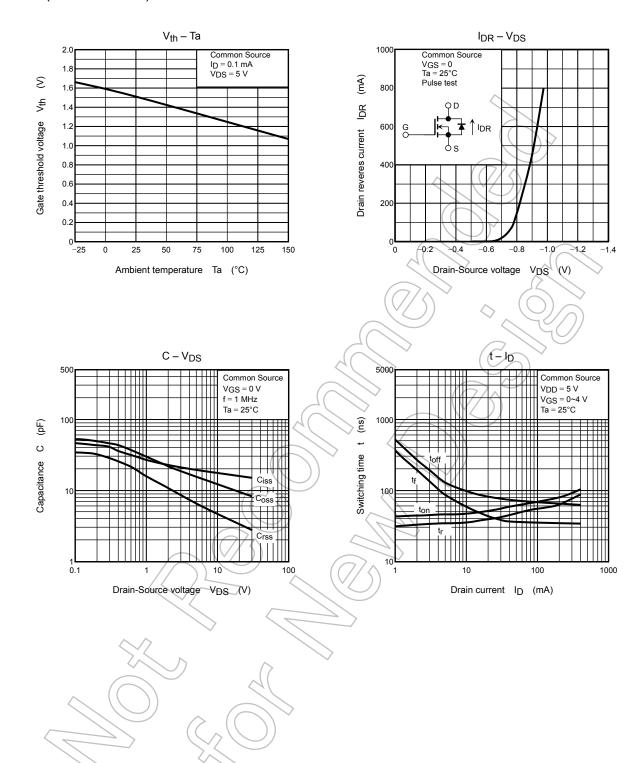
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Q1 (Nch MOS FET)

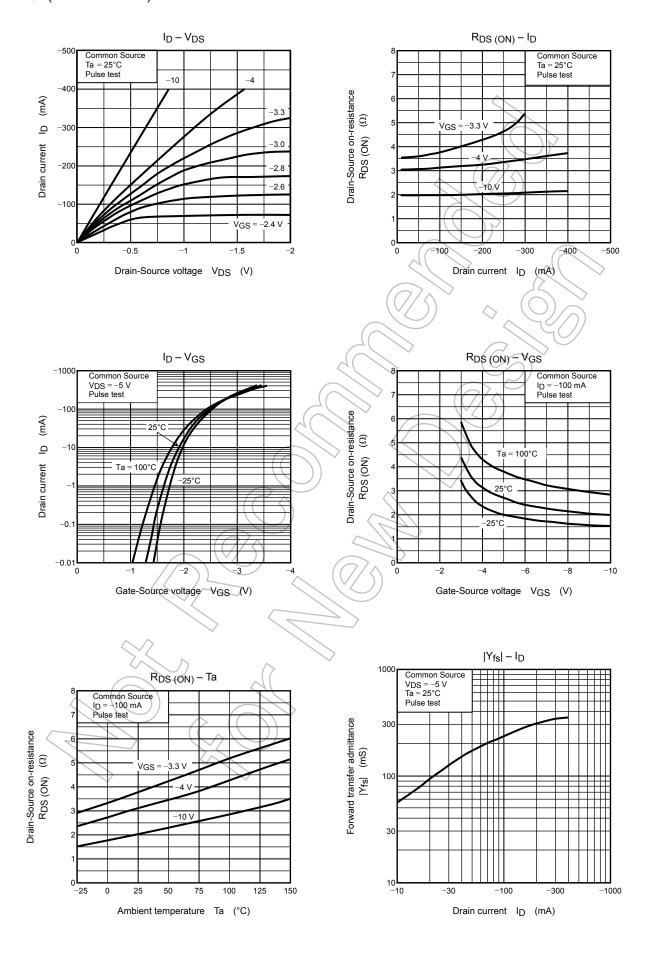


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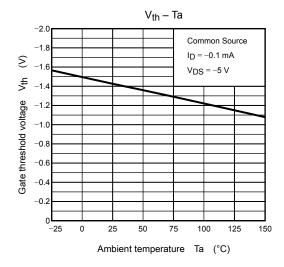
Q1 (Nch MOS FET)

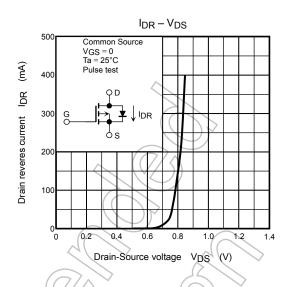


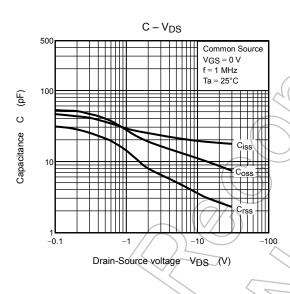
Q2 (Pch MOS FET)

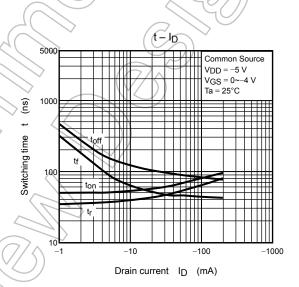


Q2 (Pch MOS FET)

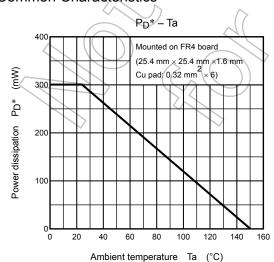








#### Common Characteristics



\*: Total rating

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